Notice of References Cited Application/Control No. 10/530,559 Examiner QIAN YANG Applicant(s)/Patent Under Reexamination MIURA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0140260	07-2003	Kizawa et al.	713/300
*	В	US-2002/0178387	11-2002	Theron, John	713/300
*	С	US-2002/0149789	10-2002	Okazawa, Takashi	358/1.14
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.